

Search Notes**Application No.**

10/051,004

Examiner

Matthew Haney

Applicant(s)

NGAI ET AL.

Art Unit

2613

SEARCHED

Class	Subclass	Date	Examiner
375	240.28	2/2/2005	MJH
375	240.03	2/2/2005	MJH
375	240.16

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See Attached Search History Notes	2/2/2005	MJH
Searched IEEE database	2/2/2005	MJH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner